

Search Notes

Application/Control No.

09/927,155

Examiner

James J. Debrow

Applicant(s)/Patent under
Reexamination

SAKAGUCHI ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched NPL in STIC database (see searched notes)	3/24/2006	JD